

<b>Notice of References Cited</b>	Application/Control No. 10/619,114		Applicant(s)/Patent Under Reexamination SHEU ET AL.	
	Examiner William M. Brewster		Art Unit 2823	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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X	B	US-6,342,429 B1	01-2002	Puchner et al.	438/424
X	C	US-5,726,095	03-1998	Noble, Wendell Phillips	438/454
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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